# **Single Synchronous Step-Down Controller**

The NCP5212A/NCP5212T is a synchronous stepdown controller for high performance systems battery-power systems. The NCP5212A/NCP5212T includes a high efficiency PWM controller. A pin is provided to allow two devices in interleaved operation. An internal power good voltage monitor tracks the SMPS output. NCP5212A/NCP5212T also features soft-start sequence, UVLO for V<sub>CC</sub> and switcher, overvoltage protection, overcurrent protection, undervoltage protection and thermal shutdown. The IC is packaged in QFN16

#### **Features**

- 0.8% accuracy 0.8 V Reference
- 4.5 V to 27 V Battery/Adaptor Voltage Range
- Adjustable Output Voltage Range: 0.8 V to 3.3 V
- Synchronization Interleaving between Two NCP5212A/NCP5212Ts
- Skip Mode for Power Saving Operation at Light Load
- Lossless Inductor Current Sensing
- Programmable Transient-Response-Enhancement (TRE) Control
- Programmable Adaptive Voltage Positioning (AVP)
- Input Supply Feedforward Control
- Internal Soft-Start
- Integrated Output Discharge (Soft-Stop)
- Build-in Adaptive Gate Drivers
- PGOOD Indication
- Overvoltage, Undervoltage and Overcurrent Protections
- Thermal Shutdown
- QFN16 Package
- These Devices are Pb-Free and are RoHS Compliant

### **Typical Applications**

- Notebook Application
- System Power



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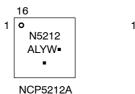
QFN16 CASE 485AP

#### **MARKING DIAGRAMS**

5212T

ALYW.

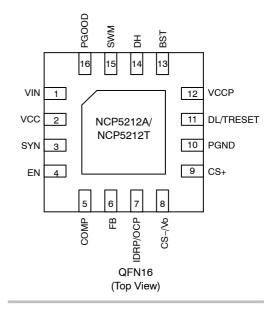
NCP5212T



N5212/5212T Device Code

= Assembly Location Α L = Wafer Lot Υ = Year W = Work Week = Pb-Free Package

(Note: Microdot may be in either location)



#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 18 of this data sheet.

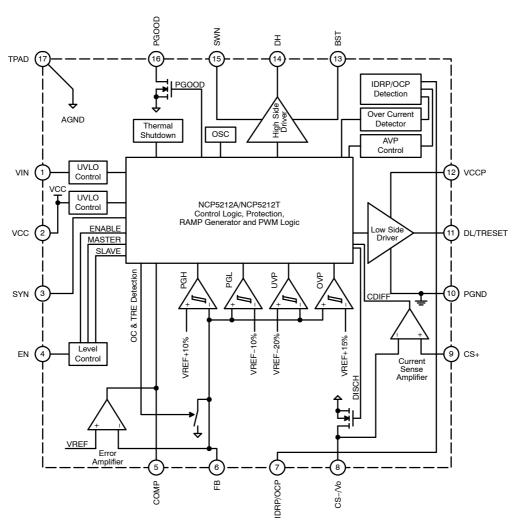


Figure 1. Detail Block Diagram

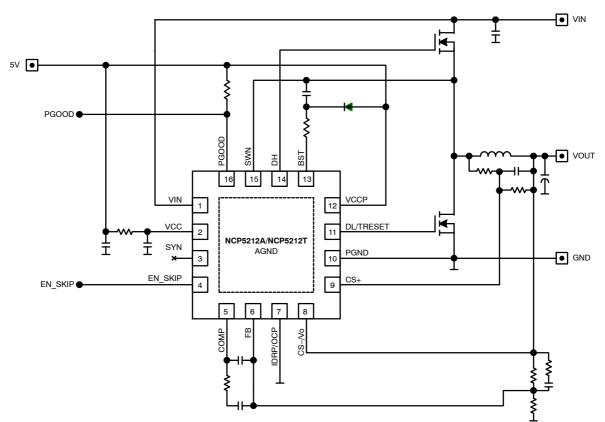


Figure 2. Typical Application Circuit (Single Device Operation)

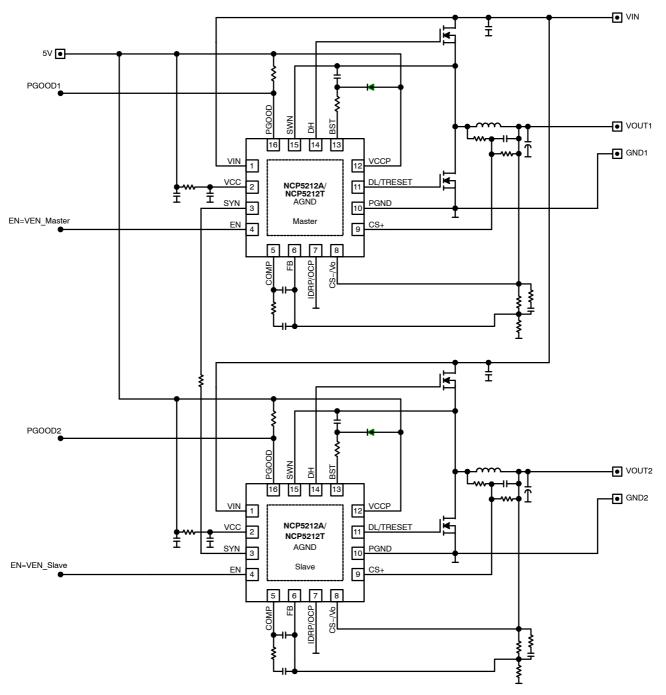


Figure 3. Typical Application Circuit (Dual Device Operation)

#### **PIN FUNCTION DESCRIPTION**

Pin No.	Symbol	Description
1	VIN	Input voltage used for feed forward in switcher operation.
2	VCC	Supply for analog circuit
3	SYN	Synchronization interleaving use.
4	EN	This pin serves as two functions. Enable: Logic control for enabling the switcher. MASTER/SLAVE: To program the device as MASTER or SLAVE mode at dual device operation.
5	COMP	Output of the error amplifier.
6	FB	Output voltage feed back.
7	IDRP/OCP	Current limit programmable and setting for AVP.
8	CS-/Vo	Inductor current differential sense inverting input.
9	CS+	Inductor current differential sense non-inverting input.
10	PGND	Ground reference and high-current return path for the bottom gate driver.
11	DL/TRESET	Gate driver output of bottom N-channel MOSFET. It also has the function for TRE threshold setting.
12	VCCP	Supply for bottom gate driver.
13	BST	Top gate driver input supply, a bootstrap capacitor connection between SWN and this pin.
14	DH	Gate driver output of top N-channel MOSFET.
15	SWN	Switch node between top MOSFET and bottom MOSFET.
16	PGOOD	Power good indicator of the output voltage. High impendence if power good (in regulation). Low impendence if power not good.
17	TPAD	Copper pad on bottom of IC used for heat sinking. This pin should be connected to the analog ground plane under the IC.

### **ABSOLUTE MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
VCC Power Supply Voltage to AGND	V <sub>CC</sub>	-0.3, 6.0	V
VIN Supply to AGND	V <sub>IN</sub>	-0.3, 30	V
High-side Gate Drive Supply: BST to SWN High-side Gate Drive Voltage: DH to SWN Low-side Gate Drive Supply: VCCP to PGND Low-side Gate Drive Voltage: DL to PGND	V <sub>BST</sub> -V <sub>SWN,</sub> V <sub>DH</sub> -V <sub>SWN,</sub> V <sub>CCP</sub> -V <sub>PGND,</sub> V <sub>DL</sub> -V <sub>PGND,</sub>	-0.3, 6.0	V
Input / Output Pins to AGND	V <sub>IO</sub>	-0.3, 6.0	٧
Switch Node SWN-PGND	V <sub>SWN</sub>	-5 V (< 100 ns) 30 V	V
High-Side Gate Drive/Low-Side Gate Drive Outputs	DH, DL	-3(DC)	V
PGND	V <sub>PGND</sub>	-0.3, 0.3	V
Thermal Characteristics Thermal Resistance Junction-to-Ambient (QFN16 Package)	$R_{ heta JA}$	48	°C/W
Operating Junction Temperature Range (Note 1)	TJ	-40 to + 150	°C
Operating Ambient Temperature Range	T <sub>A</sub>	- 40 to + 85	°C
Storage Temperature Range	T <sub>stg</sub>	– 55 to +150	°C
Moisture Sensitivity Level	MSL	1	-

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

NOTE: This device is ESD sensitive. Use standard ESD precautions when handling.

1. Internally limited by thermal shutdown, 150°C min.

**ELECTRICAL CHARACTERISTICS** ( $V_{IN}$  = 12 V,  $V_{CC}$  =  $V_{CCP}$  = 5 V,  $T_A$  =-40°C to 85°C, unless other noted)

Characteristics	Symbol	Test Conditions		Min	Тур	Max	Unit
SUPPLY VOLTAGE							
Input Voltage	V <sub>IN</sub>			4.5	-	27	V
V <sub>CC</sub> Operating Voltage	V <sub>CC</sub>			4.5	5.0	5.5	V
SUPPLY CURRENT	•	-				-	
V <sub>CC</sub> Quiescent Supply Current in Master operation	IVCC_Master	EN = VEN_Master, regulation point.	V <sub>FB</sub> forced above DH, DL are open		1.5	2.5	mA
V <sub>CC</sub> Quiescent Supply Current in Slave Operation	IVCC_Slave	EN = VEN_Slave, regulation point,			1.5	2.5	mA
V <sub>CC</sub> Shutdown Current	IVCC_SD	EN = VEN_Disable Shute				1	μΑ
BST Quiescent Supply Current in Master Operation	IBST_Master	EN = VEN_Master, regulation point, DH No boost t	l and DL are open,			0.3	mA
BST Quiescent Supply Current in Slave Operation	IBST_Slave	EN = VEN_Slave, regulation point, DI No boost t	Hand DL are open			0.3	mA
BST Shutdown Current	IBST_SD	EN =	: 0 V			1	μΑ
VCCP Shutdown Current	IVCCP_SD	EN = 0 V, \	/ <sub>CCP</sub> = 5 V			1	μΑ
VIN Supply Current	IVIN	EN = 5V, \	/ <sub>IN</sub> = 27 V			35	μΑ
VIN Shutdown Current	IVIN_SD	EN = 0 V, V <sub>IN</sub> = 27 V				1	μΑ
VOLTAGE-MONITOR							
Rising VCC Threshold	VCCth+	Wake Up		4.05	4.25	4.48	V
VCC UVLO Hysteresis	VCCHYS			200	275	400	mV
Rising VIN Threshold	VINth+	Wake Up, Design	Wake Up, Design Spec. (Note 2)		3.8	4.2	V
VIN UVLO Hysteresis	VINHYS	(Not	e 2)	200	500	800	mV
Power Good High Threshold	VPGH	PGOOD in from higher Vo	NCP5212A	105	110	115	%
		(PGOOD goes high)	NCP5212T	120	125	130	
Power Good High Hysteresis	VPGH_HYS	PGOOD high hys			5		%
Power Good Low Threshold	VPGL	PGOOD in from lo	`	80	85	90	%
Power Good Low Hysteresis	VPGL_HYS	PGOOD low hystere lov			-5		%
Power Good High Delay	Td_PGH	After Tss,	(Note 2)		1.25		ms
Power Good Low Delay	Td_PGL	(Not	e 2)		1.5		μs
Output Overvoltage Rising Threshold	OVPth+	With respect to	NCP5212A	110	115	120	%
		Error Comparator Threshold of 0.8 V	NCP5212T	125	130	135	
Overvoltage Fault Propagation Delay	OVPTblk	FB forced 2% above trip threshold (Note 2)			1.5		μs
Output Undervoltage Trip Threshold	UVPth	With respect to Error Comparator Threshold of 0.8 V		75	80	85	%
Output Undervoltage Protection Blanking Time	UVPTblk	(Note 2)		-	8/fsw	-	s
REFERENCE OUTPUT							
Internal Reference Voltage	V <sub>ref</sub>			0.7936	0.8	0.8064	V

<sup>2.</sup> Guaranteed by design, not tested in production.

**ELECTRICAL CHARACTERISTICS** ( $V_{IN}$  = 12 V,  $V_{CC}$  =  $V_{CCP}$  = 5 V,  $T_A$  =-40°C to 85°C, unless other noted)

Characteristics	Symbol	Test Co	nditions	Min	Тур	Max	Unit
OSCILLATOR							
Operation Frequency	F <sub>SW</sub>			270	300	330	kHz
OVERCURRENT THRESHOLD	-						
Total Detection Time	T <sub>DETECT</sub>		s to ground before S	1.26	1.92	2.21	ms
OCSET Detection Time	T_OCDET	(Not	te 2)	1.09		1.47	ms
INTERNAL SOFT-START				•		-	
Soft-Start Time	TSS			0.9	1.1	1.3	ms
VOLTAGE ERROR AMPLIFIER				-			
DC Gain	GAIN_VEA	(Not	re 2)		88		dB
Unity Gain Bandwidth	BW_VEA	(Not	te 2)		15		MHz
Slew Rate	SR_VEA	COMP PIN TO (Not	GND = 100 pF :e 2)		2.5		V/µs
FB Bias Current	Ibias_FB					0.1	μА
Output Voltage Swing	Vmax_EA	Isource_E	A = 2 mA	3.3	3.5		V
	Vmin_EA	Isink_EA	A = 2 mA		0.15	0.3	V
DIFFERENTIAL CURRENT SENSE AI	MPLIFIER						.1
CS+ and CS- Common-mode Input Signal Range	VCSCOM_MAX	Refer to	AGND			3.5	V
Input Bias Current	CS_IIB			-100		100	nA
Input Signal Range	CS_range			-70		70	mV
Offset Current at IDRP	IDRP_offset	(CS+) - (C	CS-) = 0 V	-1.0		1.0	μΑ
[(CS+)-(CS-)] to IDRP Gain	IDRP_GAIN	(CS+) - (CS-) =	T <sub>A</sub> = 25°C	0.475	0.525	0.575	μ <b>A</b> /mV
	(IDRP/((CS+) - (CS-)))	10 mV, V(IDRP) = 0.8 V	T <sub>A</sub> = -40°C to 85°C	0.425		0.625	μ <b>A</b> /mV
Current-Sense Bandwidth	BW_CS	At -3dB to DC	Gain (Note 2)		20		MHz
Maximum IDRP Output Voltage	IDRP_Max	(CS+) - (CS-) = 70 to 95% of the value 0.8	0 mV, Isource drops ue when V <sub>(IDRP)</sub> = 3 V	2.5			V
Minimum IDRP Output Voltage	IDRP_Min				0		V
IDRP Output current	I_IDRP			-1.0		35	μΑ
OVERCURRENT PROTECTION SETT	ING	•			•		
Overcurrent Threshold (OCTH) Detection Current	I_OCSET	Sourced from OCF Rocset = 16.7 kΩ OCP to A0	is connected from	21.6	24	26.4	μА
Ratio of OC Threshold over OCSET Votlage	K_OCSET	V((CS+) - (CS- (Not	V((CS+) - (CS-)) / V_OCSET (Note 2)		0.1		-
OCSET Voltage for Default Fixed OC Threshold	VOCSET_DFT	Rocset ≤ 2 kΩ is connected from OCP to AGND or FB				100	mV
OCSET Voltage for Adjustable OC Threshold	VOCSET_ADJ	Rocset = 8.3 ~ 25 from OCP to		200		600	mV
OCSET Voltage for OC Disable	VOCSET_DIS	Rocset ≥ 35 kΩ i OCP to A0	is connected from GND or FB	720			mV
Default Fixed OC Threshold	V_OCTH_DFT	(CS+) – (CS–), Pin AGND	OCP is shorted to or FB	35	40	45	mV

<sup>2.</sup> Guaranteed by design, not tested in production.

 $\textbf{ELECTRICAL CHARACTERISTICS} \ (V_{IN} = 12 \ V, \ V_{CC} = V_{CCP} = 5 \ V, \ T_A = -40 ^{\circ}C \ to \ 85 ^{\circ}C, \ unless \ other \ noted)$ 

Characteristics	Symbol	Test Conditions		Min	Тур	Max	Unit
OVERCURRENT PROTECTION SETT	ING						
Adjustable OC Threshold	V_OCTH ((CS+)-(CS-))	(CS+) - (CS-), During OC threshold, set a	VOCSET = 200 mV	15	20	25	mV
		voltage at pin OCP	VOCSET = 600 mV	52	60	68	
GATE DRIVERS							
DH Pull-HIGH Resistance	RH_DH	200 mA So	urce current		1		Ω
DH Pull-LOW Resistance	RL_DH	200 mA S	ink current		1		Ω
DL Pull-HIGH Resistance	RH_DL	200 mA So	urce current		1		Ω
DL Pull-LOW Resistance	RL_DL	200 mA S	ink current		0.5		Ω
DH Source Current	Isource_DH	(Not	te 2)		2.5		Α
DH Sink Current	Isink_DH	(Not	te 2)		2.5		Α
DL Source Current	Isource_DL	(Not	te 2)		2.5		Α
DL Sink Current	lsink_DL	(Not	te 2)		5		Α
Dead Time	TD_LH	DL-off to DH	I-on (Note 2)		20		ns
	TD_HL	DH-off to DL	-on (Note 2)		20		ns
Negative Current Detection Threshold	NCD_TH	SWN - PGNI	), at EN = 5 V		-1		mV
SWN source leakage	ISWN_SD	EN = 0 V, SWN = 0 V				1	μΑ
Internal Resistor from DH to SWN	R_DH_SWN	(Note 2)			100		kΩ
CONTROL SECTION							
EN Logic Input Voltage for Disable	VEN_Disable	Set as Disable		0.7	1.0	1.3	V
		Hyste	eresis	150	200	250	mV
EN Logic Input Voltage for MASTER Mode	VEN_Master	Set as Ma	ster Mode	1.7	1.95	2.25	V
EN Logic Input Voltage for SLAVE	VEN_Slave	Set as Sla	ave Mode	2.4	2.65	2.9	V
Mode		Hyste	eresis	100	175	250	mV
EN Source Current	IEN_SOURCE	VEN	= 0 V			0.1	μΑ
EN Sink Current	IEN_SINK	VEN	= 5 V			0.1	μΑ
PGOOD Pin ON Resistance	PGOOD_R	I_PGOO	D = 5 mA		100		Ω
PGOOD Pin OFF Current	PGOOD_LK					1	μΑ
SYNC CONTROL							
SYNC pin leakage	ISYNC_LK	Set as Slave Mo	ode, SYNC = 5 V			1	uA
SYNC frequency	F_SYNC	(Not	te 2)		1.2		MHz
Pulse Width	PW_SYNC	(Not	te 2)		416		ns
Clock Level Low	V_CLKL	(Not	te 2)		0		V
Clock Level High	V_CLKH	(Note 2)			5		V
SYNC Driving Capability	SYNC_CL	Set as Master Mode, load capacitor between SYNC and GND (Note 2)				20	pF
SYNC Source Current	ISYNC	SYNC shorts to ground				20	mApp
OUTPUT DISCHARGE MODE							
Output Discharge On-Resistance	Rdischarge	EN =	= 0 V		20	35	Ω
Threshold for Discharge Off	Vth_DisOff			0.2	0.3	0.4	V

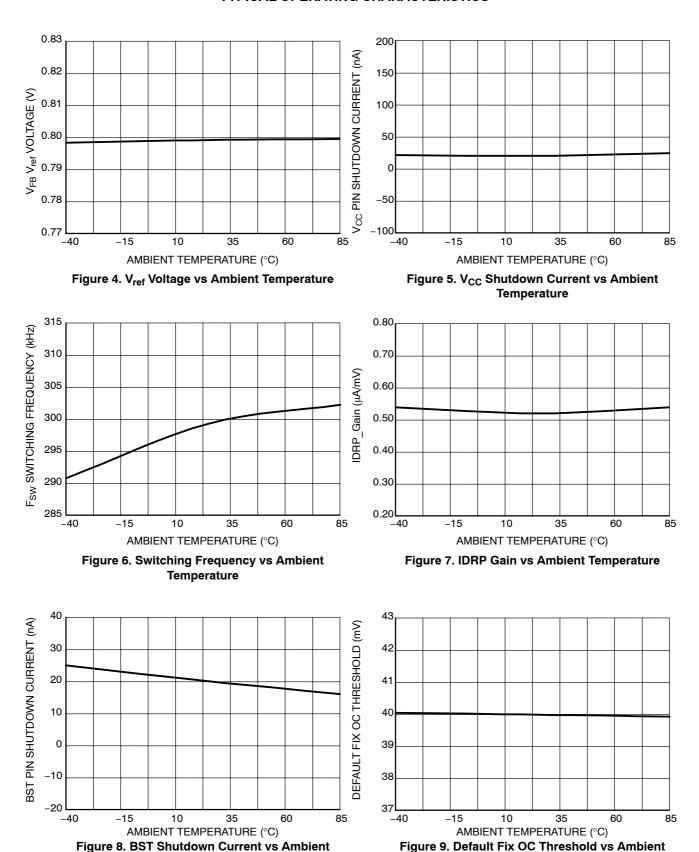
<sup>2.</sup> Guaranteed by design, not tested in production.

# $\textbf{ELECTRICAL CHARACTERISTICS} \ (V_{IN} = 12 \ V, \ V_{CC} = V_{CCP} = 5 \ V, \ T_A = -40 ^{\circ}C \ to \ 85 ^{\circ}C, \ unless \ other \ noted)$

Characteristics	Symbol	Test Co	nditions	Min	Тур	Max	Unit
TRE SETTING							
TRE Threshold Detection Current	I_TRESET	before soft-start	Sourced from DL in the short period before soft–start. (Rtre = $47 \text{ k}\Omega$ is connected from DL to GND		8	8.8	μΑ
Detection Voltage for TRE Threshold Selection	VDL_TRE_1 (Default)	Internal TRE_TH is set to 300 mV	Rtre $\geq$ 75 k $\Omega$ (Note 2)	500	600	700	mV
	VDL_TRE_2	Internal TRE_TH is set to 500 mV	Rtre = 44 – 50 k $\Omega$ (Note 2)	300		450	
	VDL_TRE_3	TRE is Disabled	Rtre $\leq$ 25 k $\Omega$ (Note 2)	0		250	
TRE Comparator Offset	TRE_OS	(No	te 2)		10		mV
Propagation Delay of TRE Comparator	TD_PWM	(Note 2)			20		ns
THERMAL SHUTDOWN	•	-			-	-	
Thermal Shutdown	Tsd	(No	te 2)		150		°C
Thermal Shutdown Hysteresis	Tsdhys	(No	te 2)		25		°C

<sup>2.</sup> Guaranteed by design, not tested in production.

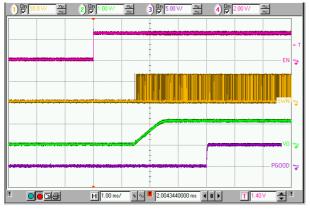
#### TYPICAL OPERATING CHARACTERISTICS



**Temperature** 

**Temperature** 

#### TYPICAL OPERATING CHARACTERISTICS



Top to Bottom: EN, SWN, Vo, PGOOD

Figure 10. Powerup Sequence



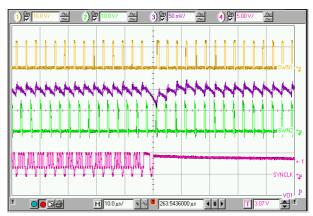
Top to Bottom: SWN\_Slave, Vo\_Slave, SWN\_Master, Sync\_clk

Figure 12. From Unsync to Sync



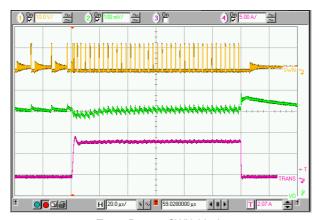
Top to Bottom: EN, SWN, Vo, PGOOD

Figure 11. Powerdown Sequence



Top to Bottom: SWN\_Slave, Vo\_Slave, SWN\_Master, Sync\_clk

Figure 13. From Sync to Unsync



Top to Bottom: SWN, Vo, Io

Figure 14. Typical Transient

### **DETAILED OPERATING DESCRIPTION**

#### General

The NCP5212A/NCP5212T synchronous stepdown power controller contains a PWM controller for wide battery/adaptor voltage range applications

The NCP5212A/NCP5212T includes power good voltage monitor, soft-start, overcurrent protection, undervoltage protection, overvoltage protection and thermal shutdown. The NCP5212A/NCP5212T features power saving function which can increase the efficiency at light load. It is ideal for battery operated systems. The IC is packaged in QFN16.

#### **Control Logic**

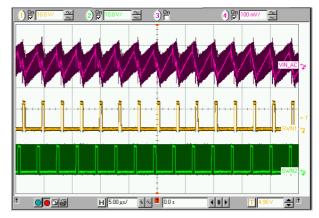
The internal control logic is powered by V<sub>CC</sub>. The device is controlled by an EN pin. The EN pin serves two functions. When voltage of EN is below VEN Disable, it shuts down the device. When the voltage of EN is at the level of VEN Master, the device is operating as Master mode. When voltage level of EN is at VEN Slave, the device is operating as Slave mode. It should be noted that no matter the device is operating either at Master or Slave mode, the device is operating in the manner of auto power saving condition such that it operates as skip mode automatically at light load. When EN is above VEN\_Disable, the internal V<sub>ref</sub> is activated and power-on reset occurs which resets all the protection faults. Once V<sub>ref</sub> reaches its regulation voltage, an internal signal will wake up the supply undervoltage monitor which will assert a "GOOD" condition. In addition, the NCP5212A/NCP5212T continuously monitors V<sub>CC</sub> and V<sub>IN</sub> levels with undervoltage lockout (UVLO) function.

### **Single Device Operation**

The device is operating as single device operation when the SYNC pin is pull to ground. Under this configuration, the device will use the internal clock for normal PWM operation.

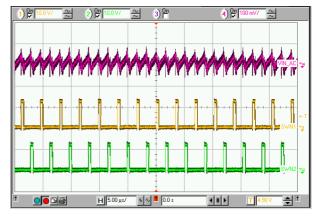
### **Dual Device Operation (Master/Salve Mode)**

The device is operating as Master/Slave mode if two devices are tied up together. (Detail configuration please see the application schematic) One device is served as Master and another one is served as Slave. Once they already, they are synchronized to each other and they are operating as "interleaved" mode such that the phase shift of their switching clocks is 180°. It has the benefit that the amount of ripple current at the V<sub>IN</sub> will be lower and hence lesser bulk capacitors at V<sub>IN</sub> to save the confined PCB space and material cost. Figure 15 and Figure 16 show the difference when the devices are operating independently (unsynchronized) and operating at interleaved mode (Synchronized). It can be seen that at the unsynchronized condition, the system is obviously noisy because of high ripple voltage at V<sub>IN</sub> (ripple voltage directly reflects the amount of ripple current at V<sub>IN</sub>). Once the devices are operating at interleaving mode, the overall V<sub>IN</sub> ripple current is significantly reduced.



Top to Bottom: VIN AC Voltage, SWN\_Slave, SWN\_Master

Figure 15. Two Devices are Unsynchronized



Top to Bottom: VIN AC Voltage, SWN Slave, SWN Master

Figure 16. Two Devices are in Interleaved Operation

### **Transient Response Enhancement (TRE)**

For the conventional PWM controller in CCM, the fastest response time is one switching cycle in the worst case. To further improve transient response in CCM, a transient response enhancement circuitry is implemented inside the NCP5212A/NCP5212T. In CCM operation, the controller is continuously monitoring the COMP pin output voltage of the error amplifier to detect the load transient events. The functional block diagram of TRE is shown below.

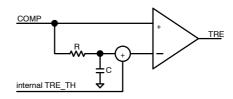


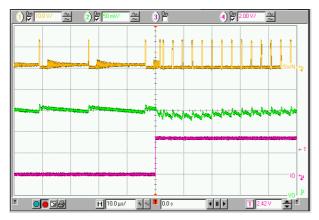
Figure 17. Block Diagram of TRE Circuit

Once the large transient occurs, the COMP signal may be large enough to exceed the threshold and then TRE "flag" signal will be asserted in a short period which is typically around one normal switching cycle. In this short period, the controller will be running at high frequency and hence has faster response. After that the controller comes back to normal switching frequency operation. We can program the internal TRE threshold (TRE TH). For detail please see the electrical table of "TRE Setting" section. Basically, the recommend internal TRE threshold value is around 1.5 times of peak-to-peak value of the COMP signal at CCM operation. The higher the internal TRE TH, the lower sensitivity to load transient. The TRE function can be disable by setting the Rtre which is connecting to DL/TRE pin to less than 25 k $\Omega$ . For system component saving, it is usually set as default value, that is, Rtre is open ( $\geq 75 \text{ k}\Omega$ ) and internal TRE\_TH is 300 mV typical.



Top to Bottom SWN, Vo, Transient Signal

Figure 18. Transient Response with TRE Disable



Top to Bottom SWN, Vo, Transient Signal

Figure 19. Transient Response with TRE Enable

#### Adaptive Voltage Positioning (AVP)

For applications with fast transient currents, adaptive voltage positioning can reduce peak—to—peak output voltage deviations due to load transients. With the use of AVP, the output voltage allows to have some controlled sag when load current is applied. Upon removal of the load, the output voltage returns no higher than the original level, just allowing one output transient peak to be cancelled over a load step up and release cycle. The amount of AVP is adjustable.

The behaviors of the V<sub>o</sub> waveforms with or without AVP are depicted at Figure 20.

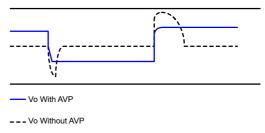


Figure 20. Adaptive Voltage Positioning

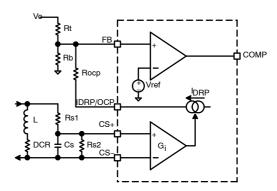


Figure 21. Configuration for AVP Function

The Figure 21 shows how to realize the AVP function. A current path is connecting to the FB pin via Rocp resistor. Rocp is not actually for AVP function, indeed, Rocp is used for OCP threshold value programming. The IDRP/OCP pin has dual functions: OCP programming and AVP. At the IDRP/OCP pin, conceptually there is a current source which is modulated by current sensing amplifier.

The output voltage Vo with AVP is:

$$V_{O} = V_{O}0 - I_{O} * R_{II}$$
 (eq. 1)

Where  $I_0$  is the load current, no load output voltage  $V_00$  is set by the external divider that is:

$$V_{O}0 = \left(1 + \frac{Rt}{Rh}\right) * V_{ref}$$
 (eq. 2)

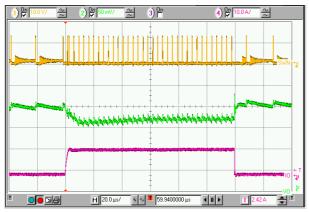
The load line impendence R<sub>LL</sub> is given by:

$$R_{LL} = DCR * Gain\_CS * Rt * \frac{Rs2}{Rs1 + Rs2}$$
 (eq. 3)

Where DCR is inductor DC resistance. Gain\_CS is a gain from [(CS+)-(CS-)] to IDRP Gain (At electrical table, the symbol is IDRP GAIN), the typical value is  $0.525 \,\mu\text{A/mV}$ .

The AVP function can be easily disable by shorting the Rocp resistor into ground.

From the equation we can see that the value of "top" resistor Rt can affect the amount of  $R_{LL}$ , so it is recommended to define the amount of  $R_{LL}$  FRIST before defining the compensation component value. And if the user wants to fine tune the compensation network for optimizing the transient performance, it is NOT recommend to adjust the value of Rt. Otherwise, both transient performance and AVP amount will be affected. The following diagram shows the typical waveform of AVP. Note that the Rt typical value should be above  $1 \ k\Omega$ .



Top to Bottom: SWN, Vo, Transient Signal

Figure 22. Typical waveform of AVP

#### **Over Current Protection (OCP)**

The NCP5212A/NCP5212T protects power system if over current event occurs. The current is continuously monitored by the differential current sensing circuit. The current limit threshold voltage VOCSET can be programmed by resistor ROCSET connecting at the IDRP/OCP pin. However, fixed default VOCSET can be achieved if ROCSET is less than 2 k $\Omega$ .

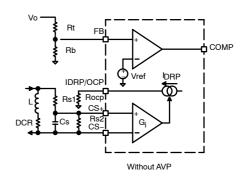
If the inductor current exceeds the current threshold continuously, the top gate driver will be turned off cycle by cycle. If it happens over consecutive 16 clock cycles time (16 x  $1/f_{SW}$ ), the device is latched off such that top and bottom gate drivers are off. EN resets or power recycle the device can exit the fault. The following diagram shows the typical behavior of OCP.



Top to Bottom: SWN, Vo, PGOOD, Io

Figure 23. Overcurrent Protection

The NCP5212A/NCP5212T uses lossless inductor current sensing for acquiring current information. In addition, the threshold OCP voltage can be programmed to some desired value by setting the programming resistor Rocp.



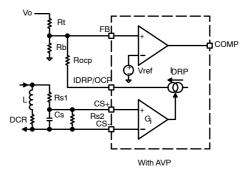


Figure 24. OCP Configuration

It should be noted that there are two configurations for Rocp resistor. If Adaptor Voltage Position (AVP) is used, the Rocp should be connected to FB pin. If AVP is not used, the Rocp should be connected to ground. At the IDRP/OCP pin, there is a constant current(24 µA typ.) flowing out during the

programming stage at system start up. This is used to sense the voltage level which is developed by a resistor Rocp so as to program the overcurrent detection threshold voltage. For typical application, the  $V_{octh}$  is set as default value(40 mV typ) by setting Rocp = 0  $\Omega$ , or directly short the IDRP/OCP pin to ground. It has the benefit of saving one component at application board. For other programming values of  $V_{octh}$ , please refer to the electrical table of "Overcurrent Protection Setting" section.

#### **Guidelines for selecting OCP Trip Component**

- 1. Choose the value of Rocp for V<sub>octh</sub> selection.
- 2. Define the DC value of OCP trip point(I<sub>OCP\_DC</sub>) that you want. The typical value is 1.5 to 1.8 times of maximum loading current. For example, if maximum loading is 10 A, then set OCP trip point at 15 A to 18 A.
- 3. Calculate the inductor peak current  $(I_{pk})$  which is estimated by the equation:

$$I_{pk} = I_{OCP\_DC} + \frac{V_o * (V_{IN} - V_o)}{2 * V_{IN} * f_{SW} * L_o}$$
 (eq. 4)

4. Check with inductor datasheet to find out the value of inductor DC resistance DCR, then calculate the RS1, RS2 dividing factor k based on the equation:

$$k = \frac{V_{octh}}{I_{pk} * DCR}$$
 (eq. 5)

- Select C<sub>S</sub> value between 100 nF to 200 nF. Typically, 100 nF will be used.
- 6. Calculate Rs1 value by the equation:

$$Rs1 = \frac{L}{k*DCR*Cs}$$
 (eq. 6)

7. Calculate Rs2 value by the equation:

$$Rs2 = \frac{k * Rs1}{1 - k}$$
 (eq. 7)

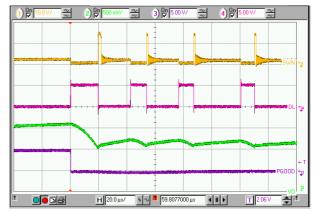
- 8. Hence, all the current sense components Rs1, Rs2, Cs had been found for taget  $I_{OCP\ DC}$ .
- 9. If Rs2 is not used (open), set  $k = \overline{1}$ , at that moment, the  $I_{pk}$  will be restricted by:

$$I_{pk} = \frac{V_{octh}}{DCR}$$
 (eq. 8)

### **Overvoltage Protection (OVP)**

When  $V_{FB}$  voltage is above OVPth+ of the nominal  $V_{FB}$  voltage for over 1.5  $\mu$ s blanking time, an OV fault is set. At that moment, the top gate drive is turned off and the bottom gate drive is turned on until the  $V_{FB}$  below lower under voltage (UV) threshold and bottom gate drive is turned on again whenever  $V_{FB}$  goes above upper UV threshold. EN

resets or power recycle the device can exit the fault. The following diagram shows the typical waveform when OVP event occurs.

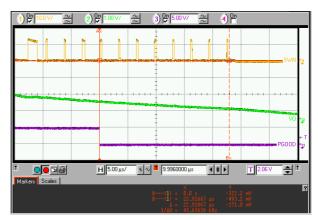


Top to Bottom: SWN, DL, Vo, PGOOD

Figure 25. Overvoltage Protection

#### **Undervoltage Protection (UVP)**

An UVP circuit monitors the  $V_{FB}$  voltage to detect under voltage event. The under voltage limit is 80% (typical) of the nominal  $V_{FB}$  voltage. If the  $V_{FB}$  voltage is below this threshold over consecutive 8 clock cycles, an UV fault is set and the device is latched off such that both top and bottom gate drives are off. EN resets or power recycle the device can exit the fault.



Top to Bottom: SWN, Vo, PGOOD

Figure 26. Undervoltage Protection

#### **Thermal Shutdown**

The IC will shutdown if the die temperature exceeds 150°C. The IC restarts operation only after the junction temperature drops below 125°C.

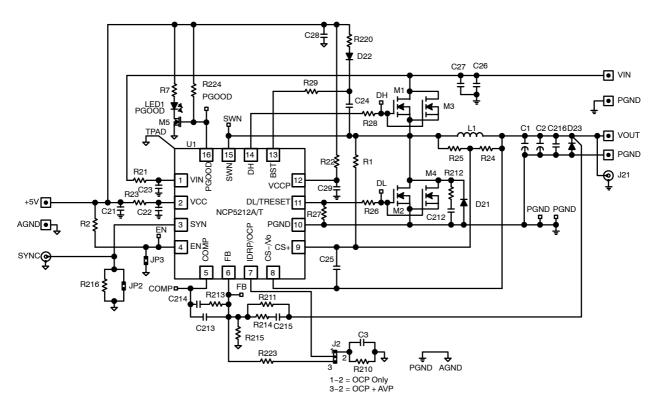


Figure 27. Demo Board Schematic

### **DEMO BOARD BILL OF MATERIAL BOM** (See next tables for compensation network and power stage)

Designator	Qty	Description	Value	Footprint	Manufacturer	Manufacturer P/N
U1	1	Single Synchronous Stepdown Controller	-	QFN 16PIN	ON Semiconductor	NCP5212MNR2G
R1	1	Chip Resistor, ±5%	DNP	_	_	_
R2	1	Chip Resistor, ±5%	10k	0603	Panasonic	ERJ3GEYJ103V
R7	1	Chip Resistor, ±5%	1k	0603	Panasonic	ERJ3GEYJ102V
R21	1	Chip Resistor, ±5%	20	0603	Panasonic	ERJ3GEYJR200V
R22	1	Chip Resistor, ±5%	0	0603	Panasonic	ERJ3GEYJR00V
R23	1	Chip Resistor, ±5%	5.6	0603	Panasonic	ERJ3GEYJR5R6V
R26	1	Chip Resistor, ±5%	0	0603	Panasonic	ERJ3GEYJR00V
R27	1	Chip Resistor, ±5%	DNP	-	-	-
R28	1	Chip Resistor, ±5%	0	0603	Panasonic	ERJ3GEYJR00V
R29	1	Chip Resistor, ±5%	5.6	0603	Panasonic	ERJ3GEYJR5R6V
R210	1	Chip Resistor, ±1%	1k	0603	Panasonic	ERJ3EKF1001V
R212	1	Chip Resistor	DNP	0603	Panasonic	ERJ3EKF2403V
R216	1	Chip Resistor, ±5%	10k	0603	Panasonic	ERJ3GEYJ103V
R220	1	Chip Resistor, ±5%	0	0603	Panasonic	ERJ3GEYJR00V
R223	1	Chip Resistor, ±1%	1k	0603	Panasonic	ERJ3EKF1001V
R224	1	Chip Resistor, ±5%	100k	0603	Panasonic	ERJ3GEYJ104V
C3	1	-	DNP	-	-	-
C21	1	MLCC Chip Capacitor, ±20% Temp Char: X5R, Rate V = 25 V,	1 μF	0805	Panasonic	ECJ2FB1E105M
C22	1	MLCC Chip Capacitor, ±20% Temp Char: X5R, Rate V = 25 V	1 μF	0805	Panasonic	ECJ2FB1E105M
C23	1	MLCC Chip Capacitor, ±10% Temp Char: X7R, Rate V = 50 V	15 nF	0805	Panasonic	ECJ1VB1E153K
C24	1	MLCC Chip Capacitor, ±10% Temp Char: X7R, Rate V = 50 V	100 nF	0603	Panasonic	ECJ1VB1E104K
C25	1	MLCC Chip Capacitor Temp Char: X7R, ±10% Rate V = 50 V	100 nF	0603	Panasonic	ECJ1VB1E104K
C26	1	MLCC Chip Capacitor Temp Char: X5R, $\pm$ 20% Rate V = 25 V	10 μF	1206	Panasonic	ECJ3YB1E106M
C27	1	MLCC Chip Capacitor Temp Char: X5R, $\pm$ 20% Rate V = 25 V	10 μF	1206	Panasonic	ECJ3YB1E106M
C28	1	MLCC Chip Capacitor Temp Char: X5R, $\pm$ 20% Rate V = 25 V	10 μF	1206	Panasonic	ECJ3YB1E106M
C29	1	MLCC Chip Capacitor Temp Char: X5R, $\pm$ 20% Rate V = 25 V	1 μF	1206	Panasonic	ECJ3YB1E105M
C212	1		DNP	-	-	-
C216	1	MLCC Chip Capacitor Temp Char: X5R, $\pm$ 20% Rate V = 25 V	1 μF	0805	Panasonic	ECJ2FB1E105M
M5	1	Power MOSFET 50 V, 200 mA Single N-Ch	-	SOT-23	ON Semiconductor	BSS138L
D21	1	-	DNP	_	_	_
D22	1	30 V Schottky Diode Vf = 0.35 V @ 10 mA	-	SOT-23	ON Semiconductor	BAT54LT1
D23	1	-	DNP	_	_	
SYNC, J21	2	SMB SMT Straight Socket	_	5.1 x 5.1 mm	Tyco Electonics	RS Stock# 420-540
JP2, JP3, J2, EN, FB, COMP, DH, DL, SWN, PGOOD, PGND, PGND	12	Pin Header Single Row	-	Pitch = 2.54 mm	Betamax	2211S-40G-F1
LED1	1	Surface Mount LED Color = Green	-	0805	LUMEX	SML-LX0805GC-T
+5V, AGND, GND, VOUT, VIN, PGND	1	Terminal Pin	-	f = 1.74 mm	HARWIN	H2121-01

# **DEMO BOARD BILL OF MATERIAL** ( $V_0 = 1.1 \text{ V}, I_0 = 18 \text{ A}$ )

Item	Component	Value	Tol	Footprint	Manufacturer	Manufacturer P/N
	R211	3k	1%	0603	Panasonic	ERJ3EKF3001V
	R213	68k	1%	0603	Panasonic	ERJ3EKF6802V
	R214	300	1%	0603	Panasonic	ERJ3EKF3000V
Compensation Network	R215	8k	1%	0603	Panasonic	ERJ3EKF8001V
	C213	24 pF	10%	0603	Panasonic	ECJ1VC1H241K
	C214	470 pF	10%	0603	Panasonic	ECJ1VB1H471K
	C215	820 pF	10%	0603	Panasonic	ECJ1VB1H821K
	M1, M3	-	-	SOIC8-FL	ON Semiconductor	NTMFS4821N
	M2, M4	-	-	SOIC8-FL	ON Semiconductor	NTMFS4847N
	L1	0.56 μΗ	20%	10x11.5 mm	Cyntec	PCMC104T-R56MN
Power Stage & Current Sense	R24	DNP	-	-	-	-
	R25	4k	1%	0603	Panasonic	ERJ3EKF4301V
	C1, C2, C2A*	330 uF	20%	7343	Panasonic	EEFSX0D331XR
		6 mΩ			Sanyo	2TPLF330M6

<sup>\*</sup>C2A is the capacitor soldered right beside of C2.

# DEMO BOARD BILL OF MATERIAL ( $V_0$ = 1.5 V, $I_0$ = 8 A)

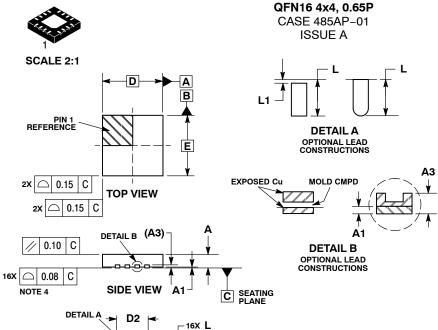
Item	Component	Value	Tol	Footprint	Manufacturer	Manufacturer P/N
	R211	5k	1%	0603	Panasonic	ERJ3EKF5001V
	R213	75k	1%	0603	Panasonic	ERJ3EKF7502V
	R214	1k	1%	0603	Panasonic	ERJ3EKF1001V
Compensation Network	R215	5.6k	1%	0603	Panasonic	ERJ3EKF5601V
	C213	9 pF	10%	0603	Panasonic	ECJ1VC1H900K
	C214	270 pF	10%	0603	Panasonic	ECJ1VB1H271K
	C215	330 pF	10%	0603	Panasonic	ECJ1VB1H331K
	M1, M2	-	-	SO8	ON Semiconductor	NTMS4705N
	M3, M4	DNP	-	-	-	-
	L1		20%	10x11.5 mm	Cyntec	PCMC104T-1R0MN
Power Stage &		1 μΗ	20%	13x14x4.9mm	WE	744315120
Current Sense	R24	DNP	-	-	-	-
	R25	4.3k	1%	0603	Panasonic	ERJ3EKF4301V
	C1, C2	220 μF 12 mΩ	20%	7343	Panasonic	EEFUD0D221XR
		12 11152			Sanyo	2R5TPL220MC

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NCP5212AMNTXG	QFN16 (Pb-Free)	3000 / Tape & Reel
NCP5212TMNTXG	QFN16 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





CAB

NOTE 3

0.10

#### **DATE 20 MAY 2009**

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION b APPLIES TO PLATED

  - TERMINAL AND IS MEASURED BETWEEN
- 0.15 AND 0.30 MM FROM TERMINAL TIP. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS							
DIM	MIN	MAX						
Α	0.80	1.00						
A1	0.00	0.05						
АЗ	0.20	REF						
b	0.25	0.35						
D	4.00	BSC						
D2	2.00	2.20						
Е	4.00	BSC						
E2	2.00	2.20						
е	0.65	BSC						
K	0.20							
L	0.45	0.65						
L1		0.15						

#### **GENERIC** MARKING DIAGRAM\*



XXXX = Specific Device Code

= Assembly Location

= Wafer Lot L Υ = Year W = Work Week = Pb-Free Package

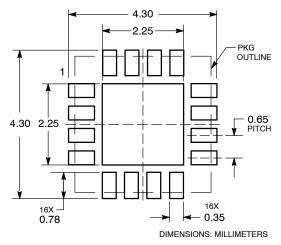
\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present.

### **MOUNTING FOOTPRINT\***

е

**BOTTOM VIEW** 

Ф 0.05 С



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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